



COMPLEMENTARY 30V ENHANCEMENT MODE MOSFET H-BRIDGE

Product Summary

Device	BV _{DSS}	R _{DS(ON)} max	I _D max T _A = +25°C
N-Channel	30V	0.12Ω @ V _{GS} = 10V	3.1A
P-Channel	-30V	0.21Ω @ V _{GS} = -10V	-2.3A

Description

This new generation of trench MOSFETs from Zetex utilizes a unique structure that combines the benefits of low on-resistance with fast switching speed. This makes them ideal for high efficiency, low voltage, power management applications.

Applications

• Single Phase DC Fan Motor Drive

Features

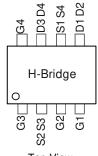
- Low On-Resistance
- Fast Switching Speed
- Low Threshold
- Low Gate Drive
- Single SM-8 Surface Mount Package
- Lead-Free Finish; RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Mechanical Data

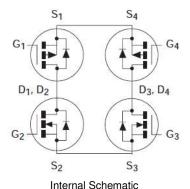
- Case: SM-8 (8 LEAD SOT223)
- Case Material: Molded Plastic, "Green" Molding Compound;
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe;
 Solderable per MIL-STD-202, Method 208 (3)
- Weight: 0.117 grams (Approximate)



Top View



Top View Pin Configuration



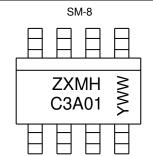
Ordering Information (Note 4)

Part Number	REEL SIZE	TAPE WIDTH	QUANTITY PER REEL
ZXMHC3A01T8TA	7"	12mm	1,000 units

Notes:

- 1. EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant. All applicable RoHS exemptions applied.
- See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



ZXMHC3A01 = Product Type Marking Code YWW = Date Code Marking Y or \overline{Y} = Last Digit of Year (ex: 5= 2015) WW or \overline{W} W = Week Code (01~53)



Maximum Ratings (@ $T_A = +25^{\circ}C$, unless otherwise specified.)

Characteris	Symbol	N-channel	P-channel	Units		
Drain-Source Voltage	V_{DSS}	30	-30	V		
Gate-Source Voltage	V _{GSS}	±20	±20	V		
Continuous Drain Current, $V_{GS} = 10V$ (Note 8) Steady State $T_A = +25^{\circ}C$ (Note 6 & 8) $T_A = +70^{\circ}C$ (Note 6 & 8) $T_A = +25^{\circ}C$ (Note 5 & 8)				3.1 2.5 2.7	-2.3 -1.8 -2.0	Α
Continuous Source Current (body diode) (Note 6)	Is	2.3	-2.2	Α		
Pulsed Drain Current (Note 7)	I _{DM}	14.3	-10.8	Α		
Pulsed Source Current (Note 7)	I _{SM}	14.5	-10.8	Α		

Thermal Characteristics (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Value	Units	
Total Power Dissipation (Note 8) Linear Derating Factor	T _A = +25°C (Note 5)	P_D	1.3 10.4	W mW/°C
Total Power Dissipation (Note 8) Linear Derating Factor	T _A = +25°C (Note 6)	P _D	1.7 13.6	W mW/°C
Thermal Resistance, Junction to Ambient (Note 8)	Steady State (Note 5)	Б	96	°C/W
memial nesistance, junction to Ambient (Note o)	Steady State (Note 6)	− R _{θJA}	73	°C/W
Operating and Storage Temperature Range	T _{J,} T _{STG}	-55 to +150	°C	

- 5. For a device surface mounted on 50mm x 50mm x 1.6mm FR4 PCB with high coverage of single sided 2oz copper, in still air conditions..
- 6. For a device surface mounted on FR4 PCB measured at t ≤10 seconds.
 7. Repetitive rating 50mm x 50mm x 1.6mm FR4 PCB, D = 0.02, pulse width 300µs pulse width limited by maximum junction temperature. Refer to transient thermal Impedance graph.
- 8. For device with one active die.



Electrical Characteristics N-CHANNEL (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	30		_	V	$V_{GS} = 0V, I_D = 250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}	_	_	1.0	μΑ	$V_{DS} = 30V$, $V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	_	_	100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS						
Gate Threshold Voltage	V _{GS(th)}	1.0	_	3.0	V	$V_{DS}=V_{GS},\ I_D=250\mu A$
Static Drain-Source On-Resistance (Note 9)		_	_	0.12	Ω	$V_{GS} = 10V, I_D = 2.5A$
Static Drain-Source On-Nesistance (Note 9)	R _{DS} (ON)	_	_	0.18	12	$V_{GS} = 4.5V, I_D = 2.0A$
Forward Transfer Admittance (Notes 9 & 11)	9 _{fs}	_	3.5	_	S	$V_{DS} = 4.5V, I_D = 2.5A$
Diode Forward Voltage (Note 9)	V_{SD}	_	_	0.95	V	$V_{GS} = 0V, I_{S} = 1.7A$
DYNAMIC CHARACTERISTICS (Note 11)						
Input Capacitance	C _{iss}	_	190	_		V_{DS} = 25V, V_{GS} = 0V, f = 1MHz
Output Capacitance	Coss	_	38	_	pF	
Reverse Transfer Capacitance	C _{rss}	_	20	_		
Total Gate Charge (Note 10)	Qg	_	3.9	_		
Gate-Source Charge (Note 10)	Qgs	_	0.6	_	nC	$V_{DS} = 15V, I_D = 2.5A, V_{GS} = 10V$
Gate-Drain Charge (Note 10)	Q_{gd}	_	0.9	_		
Turn-On Delay Time (Note 10)	t _{D(on)}	_	1.7	_		
Turn-On Rise Time (Note 10)	t _r		2.3	_		$\begin{split} V_{DD} &= 15 V, \ V_{GS} = 10 V, \\ I_D &= 2.5 A, \ R_G \cong 6.0 \Omega, \end{split}$
Turn-Off Delay Time (Note 10)	t _{D(off)}	_	6.6	_	ns	
Turn-Off Fall Time	t _f	_	2.9	_		
Reverse Recovery Time	t _{rr}	_	17.7	_	ns	1 1 0 4 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1 1
Reverse Recovery Charge	Qrr	_	13	_	$I_{S} = 1.8A, di/dt = 100A/\mu s$	

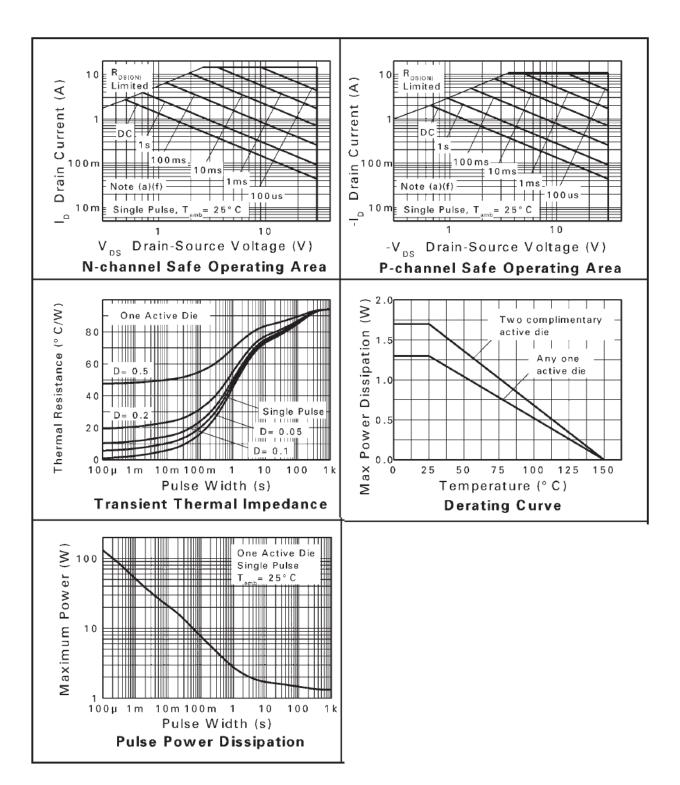
Electrical Characteristics P-CHANNEL (@TA = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition
OFF CHARACTERISTICS		-		1		
Drain-Source Breakdown Voltage	BV _{DSS}	-30	_	_	V	$V_{GS} = 0V, I_{D} = -250\mu A$
Zero Gate Voltage Drain Current	I _{DSS}		_	-1.0	μΑ	$V_{DS} = -30V, V_{GS} = 0V$
Gate-Source Leakage	I _{GSS}	_	_	100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$
ON CHARACTERISTICS	•					
Gate Threshold Voltage	V _{GS(th)}	-1.0	_	-3.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$
Static Drain-Source On-Resistance (Note 9)		-	_	0.21	Ω	$V_{GS} = -10V, I_D = -1.4A$
	R _{DS} (ON)	_	_	0.33		$V_{GS} = -4.5V, I_D = -1.1A$
Forward Transfer Admittance (Notes 9 & 11)	9fs	_	2.5	_	S	$V_{DS} = -15V, I_D = -1.4A$
Diode Forward Voltage (Note 9)	V _{SD}	_	-0.85	-0.95	V	$V_{GS} = 0V, I_{S} = -1.1A$
DYNAMIC CHARACTERISTICS (Note 11)	•					
Input Capacitance	C _{iss}	-	204	_	рF	451/1/
Output Capacitance	C _{oss}	_	39.8	_	pF	$V_{DS} = -15V, V_{GS} = 0V,$ -f = 1MHz
Reverse Transfer Capacitance	C _{rss}	_	25.8	_	pF	71 = 11VIFIZ
Gate Charge (V _{GS} = -5.0V) (Note 10)	Qg	_	2.6	_	nC	
Total Gate Charge (V _{GS} = -10V) (Note 10)	Qg	_	5.2	_	nC	V _{DS} = -15V. I _D = -1.4A.
Gate-Source Charge (Note 10)	Q _{gs}	_	0.7	_	nC	$V_{DS} = -15V, I_D = -1.4A,$
Gate-Drain Charge (Note 10)	Q _{gd}	_	0.9	_	nC	7
Turn-On Delay Time (Note 10)	t _{D(on)}	_	1.2	_	ns	
Turn-On Rise Time (Note 10)	tr		2.3	_	ns	V _{DD} = -15V, V _{GS} = -10V,
Turn-Off Delay Time (Note 10)	t _{D(off)}	_	12.1	_	ns	$R_G \cong 6.0\Omega$, $I_D = -1.0A$
Turn-Off Fall Time	t _f		7.5	_	ns	7
Reverse Recovery Time	t _{rr}	_	19	_	ns	
Reverse Recovery Charge	Q _{rr}	_	15	_	nC	$I_S = -0.95A$, di/dt = 100A/ μ s

Notes:

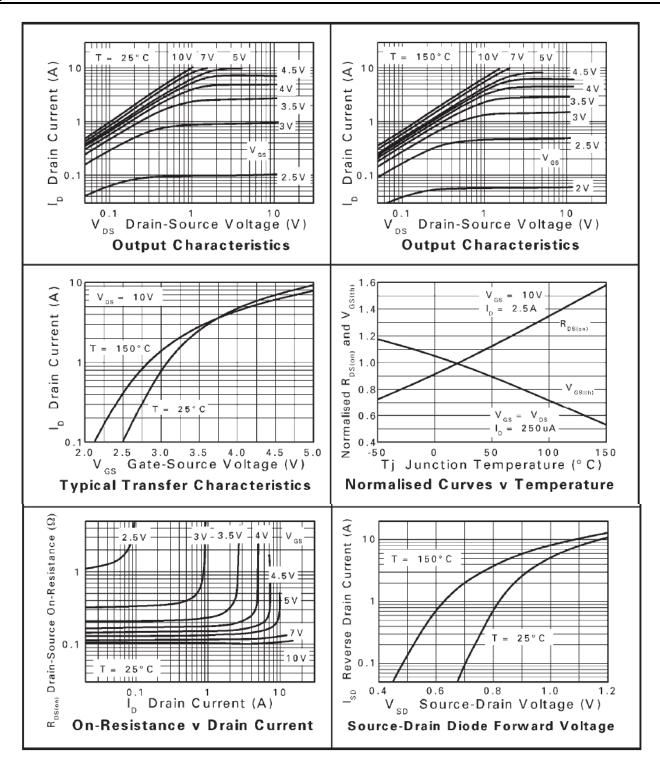
Measured under pulsed conditions. Width≤300µs. Duty cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperature.
 For design aid only, not subject to production testing.





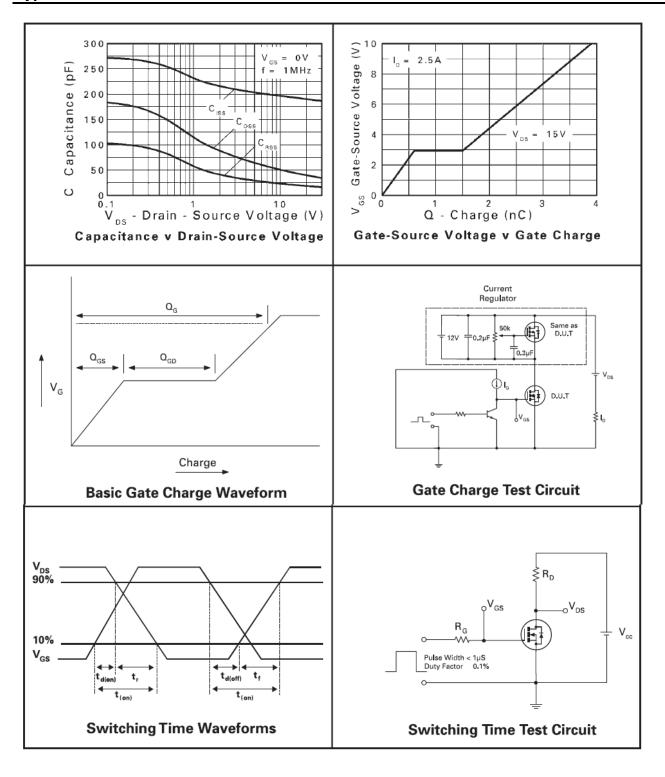


Typical Characteristics N-CHANNEL



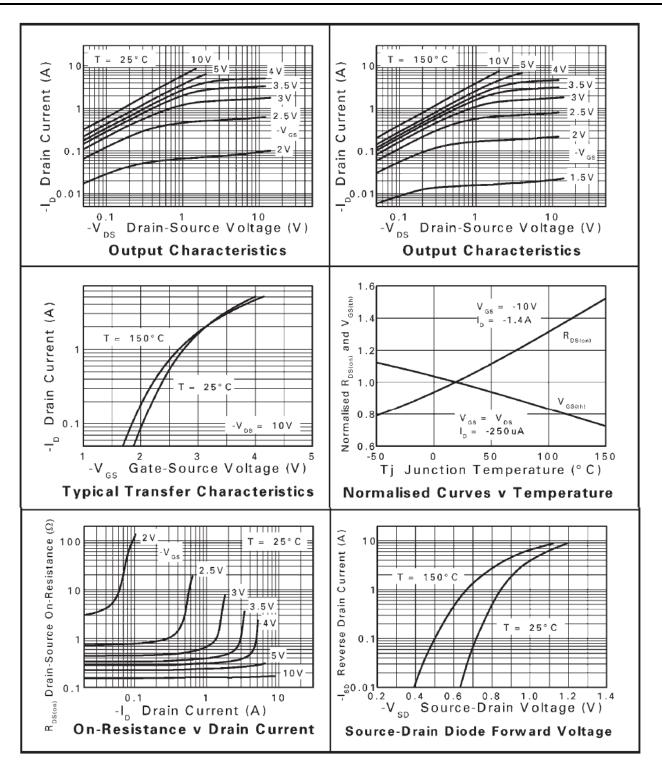


Typical Characteristics N-CHANNEL



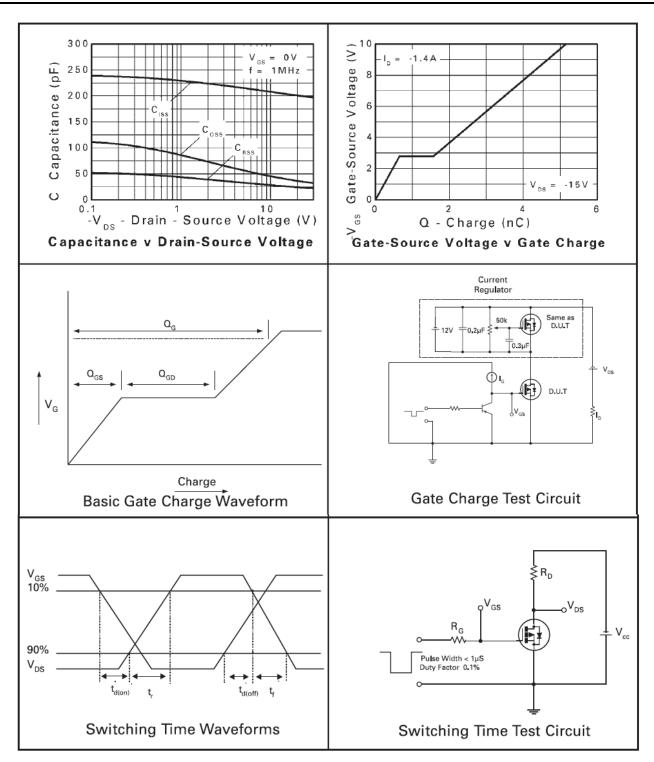


Typical Characteristics P-CHANNEL





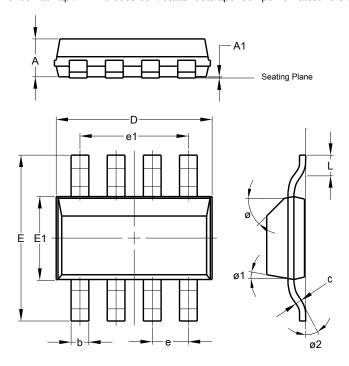
Typical Characteristics P-CHANNEL





Package Outline Dimensions

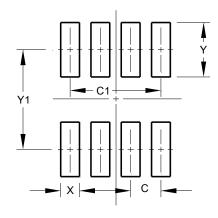
Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for latest version.



SM-8							
Dim	Min Max Typ						
Α		1.70	1.60				
A1	0.02	0.10	0.04				
b	0.70	0.90 0.80					
С	0.24	0.24 0.32 0.28					
D	6.30 6.70 6.60						
е	1.53 REF						
e1	4.59 REF						
Е	6.70	.70 7.30 7.00					
E1	3.30	3.70	3.50				
L	0.75	1.00	0.90				
Ø	45°						
Ø1		15°					
Ø2			10°				
All Dimensions in mm							

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Dimensions	Value (in mm)
С	1.52
C1	4.60
X	0.95
Υ	2.80
V1	6.80



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